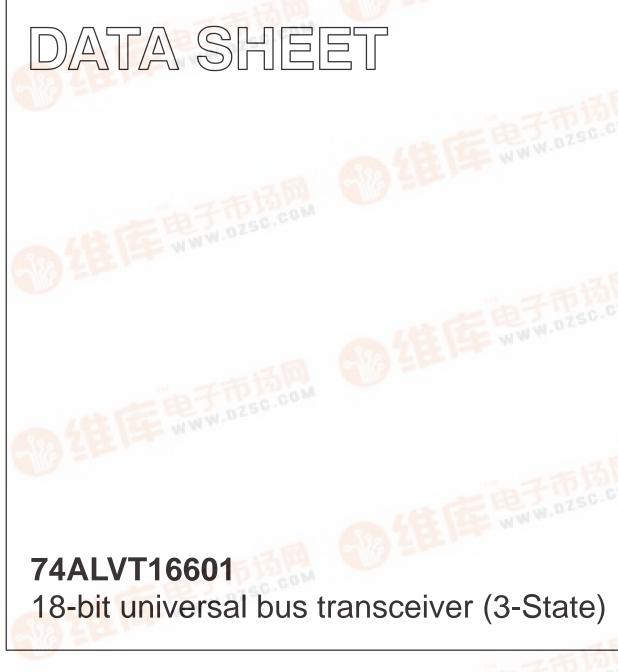
INTEGRATED CIRCUITS

查询"74ALVT16601DL"供应商

WW W



Product specification Supersedes data of 1996 Nov 14 IC23 Data Handbook 1998 Feb 13







2.5V/3.3V-18-bit universal bus transceiver (3-State)

74ALVT16601

FEATURES

- 18-bit bidirectional bus interface
- 5V I/O Compatible
- 3-State buffers
- Output capability: +64mA/-32mA
- TTL input and output switching levels
- Input and output interface capability to systems at 5V supply
- Bus-hold data inputs eliminate the need for external pull-up resistors to hold unused inputs
- Live insertion/extraction permitted
- Power-up reset
- Power-up 3-State
- No bus current loading when output is tied to 5V bus
- Positive edge triggered clock inputs
- Latch-up protection exceeds 500mA per JEDEC Std 17
- ESD protection exceeds 2000V per MIL STD 883 Method 3015 and 200V per Machine Model

DESCRIPTION

The 74ALVT16601 is a high-performance BiCMOS product designed for V_{CC} operation at 2.5V and 3.3V with I/O compatibility up to 5V.

This device is an 18-bit universal transceiver featuring non-inverting 3-State bus compatible outputs in both send and receive directions. Data flow in each direction is controlled by output enable (OEAB and OEBA), latch enable (LEAB and LEBA), and clock (CPAB and CPBA) inputs. For A-to-B data flow, the device operates in the transparent mode when LEAB is High. When LEAB is Low, the A data is latched if CPAB is held at a High or Low logic level. If LEAB is Low, the A-bus data is stored in the latch/flip-flop on the Low-to-High transition of CPAB. When OEAB is Low, the outputs are active. When OEAB is High, the outputs are in the high-impedance state. The clocks can be controlled with the clock-enable inputs (CEBA/CEAB).

Data flow for B-to-A is similar to that of A-to-B but uses $\overline{\text{OEBA}}$, LEBA and CPBA.

Active bus-hold circuitry is provided to hold unused or floating data inputs at a valid logic level.

QUICK REFERENCE DATA

CYMDOL	PARAMETER	CONDITIONS	ТҮРІ	UNUT	
SYMBOL		T _{amb} = 25℃	2.5V	3.3V	UNIT
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	$C_L = 50 pF$	1.9 2.5	1.5 1.9	ns
C _{IN}	Input capacitance (Control pins)	$V_I = 0V \text{ or } V_{CC}$	4	4	pF
C _{I/O}	I/O pin capacitance	Outputs disabled; $V_{I/O} = 0V$ or V_{CC}	8	8	pF
I _{CCZ}	Total supply current	Outputs disabled	40	60	μΑ

ORDERING INFORMATION

PACKAGES	TEMPERATURE RANGE	OUTSIDE NORTH AMERICA	NORTH AMERICA	DWG NUMBER
56-Pin Plastic SSOP Type III	–40°C to +85°C	74ALVT16601 DL	AV16601 DL	SOT371-1
56-Pin Plastic TSSOP Type II	–40°C to +85°C	74ALVT16601 DGG	AV16601 DGG	SOT364-1

PIN DESCRIPTION

PIN NUMBER	SYMBOL	NAME AND FUNCTION
1, 27	OEAB/OEBA	A-to-B/ B-to-A Output enable input (active Low)
29, 56	CEBA/CEAB	B-to-A/A-to-B clock enable
2, 28	LEAB/LEBA	A-to-B/B-to-A Latch enable input
55,30	CPAB/CPBA	A-to-B/B-to-A Clock input (active rising edge)
3, 5, 6, 8, 9, 10, 12, 13, 14, 15, 16, 17, 19, 20, 21, 23, 24, 26	A0-A17	Data inputs/outputs (A side)
54, 52, 51, 49, 48, 47, 45, 44, 43, 42, 41, 40, 38, 37, 36, 34, 33, 31	B0-B17	Data inputs/outputs (B side)
4, 11, 18, 25, 32, 39, 46, 53	GND	Ground (0V)
7, 22, 35, 50	V _{CC}	Positive supply voltage

25V/3AV-18-bit universal bus transceiver (3-State)

74ALVT16601

PIN CONFIGURATION

		<u> </u>	
OEAB		56	CEAB
LEAB	2	55	CPAB
AO	3	54	B0
GND	4	53	GND
A1	5	52	B1
A2	6	51	B2
V _{CC}	7	50	VCC
A3	8	49	B3
A4	9	48	B4
A5	10	47	B5
GND	11	46	GND
A6	12	45	B6
A7	13	44	B7
A8	14	43	B8
A9	15	42	B9
A10	16	41	B10
A11	17	40	B11
GND	18	39	GND
A12	19	38	B12
A13	20	37	B13
A14	21	36	B14
VCC	22	35	VCC
A15	23	34	B15
A16	24	33	B16
GND	25	32	GND
A17	26	31	B17
OEBA	27	30	СРВА
LEBA	28	29	CEBA
		SW00192	

FUNCTION TABLE

	INPUTS						
CEAB	OEAB	LEAB	CPAB	Α	В		
Х	Н	Х	Х	Х	Z		
Х	L	Н	Х	L	L		
Х	L	Н	Х	Н	Н		
Н	L	L	Х	Х	Β _Ο ±		
L	L	L	↑	L	L		
L	L	L	↑	Н	Н		
L	L	L	Н	Х	Β _Ο ±		
L	L	L	L	Х	В _О §		

X = Don't care

H = High voltage levelL = Low voltage level $\uparrow = Low to High$

Z = High impedance "off" state† = A-to-B data flow is shown: B-to-A flow is similar but usesOEBA, LEBA, CPBA, and CEBA.

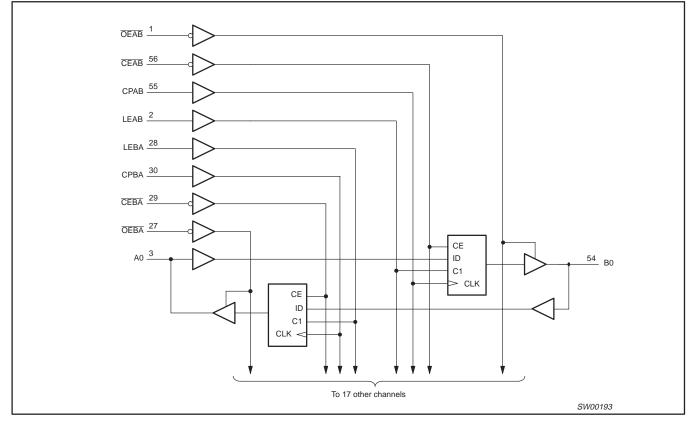
 \pm = Output level before the indicated steady-state input conditions were established.

§ = Output level before the indicated steady-state input conditions were established, provided that CPAB was Low before LEAB went Low.

2.5V/3.3V-18-bit universal bus transceiver (3-State) 查询//4A2VT16601DL中供应商

74ALVT16601

LOGIC SYMBOL (Positive Logic)



ABSOLUTE MAXIMUM RATINGS ^{1, 2}

SYMBOL	PARAMETER	CONDITIONS	RATING	UNIT
V _{CC}	DC supply voltage		-0.5 to +4.6	V
I _{IK}	DC input diode current	V ₁ < 0	-50	mA
VI	DC input voltage ³		-0.5 to +7.0	V
I _{OK}	DC output diode current	V _O < 0	-50	mA
V _{OUT}	DC output voltage ³	Output in Off or High state	-0.5 to +7.0	V
	DC output current	Output in Low state	128	mA
IOUT	DC oulput current	Output in High state	-64	
T _{stg}	Storage temperature range		-65 to +150	°C

NOTES:

1. Stresses beyond those listed may cause permanent damage to the device. These are stress ratings only and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

 The performance capability of a high-performance integrated circuit in conjunction with its thermal environment can create junction temperatures which are detrimental to reliability. The maximum junction temperature of this integrated circuit should not exceed 150°C.

3. The input and output negative voltage ratings may be exceeded if the input and output clamp current ratings are observed.

25V/33V-18-bit universal bus transceiver (3-State)

74ALVT16601

RECOMMENDED OPERATING CONDITIONS

SYMBOL	PARAMETER	2.5V RAN	2.5V RANGE LIMITS		GE LIMITS	UNIT
STMDUL		MIN	MAX	MIN	MAX	UNIT
V _{CC}	DC supply voltage	2.3	2.7	3.0	3.6	V
VI	Input voltage	0	5.5	0	5.5	V
VIH	High-level input voltage	1.7		2.0		V
V _{IL}	Input voltage		0.7		0.8	V
I _{ОН}	High-level output current		-8		-32	mA
lai	Low-level output current		8		32	mA
IOL	Low-level output current; current duty cycle \leq 50%; f \geq 1kHz		24		64	IIIA
$\Delta t / \Delta v$	Input transition rise or fall rate; Outputs enabled		10		10	ns/V
T _{amb}	Operating free-air temperature range	-40	+85	-40	+85	°C

DC ELECTRICAL CHARACTERISTICS (3.3V ± 0.3V RANGE)

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS	TEST CONDITIONS		-40°C to	+85°C	UNIT
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	$V_{CC} = 3.0V; I_{IK} = -18mA$			-0.85	-1.2	V
V _{OH}	High-level output voltage	$V_{CC} = 3.0$ to 3.6V; $I_{OH} = -100\mu A$	V _{CC} = 3.0 to 3.6V; I _{OH} = -100µA		V _{CC}		v
VOH	l lightevel output voltage	$V_{CC} = 3.0V; I_{OH} = -32mA$		2.0	2.3		v
		V _{CC} = 3.0V; I _{OL} = 100µA			0.07	0.2	
Va	Low-level output voltage	V _{CC} = 3.0V; I _{OL} = 16mA			0.25	0.4	v
V _{OL}		V _{CC} = 3.0V; I _{OL} = 32mA			0.3	0.5	v
		$V_{CC} = 3.0V; I_{OL} = 64mA$			0.4	0.55	
V _{RST}	Power-up output low voltage ⁶	V_{CC} = 3.6V; I_O = 1mA; V_I = V_{CC} or GND				0.55	V
		$V_{CC} = 3.6V; V_I = V_{CC} \text{ or } GND$	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 3.6 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$			0.1	10	μΑ
I _I	I _I Input leakage current	$V_{CC} = 3.6V; V_{I} = 5.5V$			0.1	20	
		$V_{CC} = 3.6V; V_I = V_{CC}$	Data pins ⁴		0.5	10	
		$V_{CC} = 3.6V; V_{I} = 0V$			0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$			0.1	±100	μA
	Bus Hold current	$V_{CC} = 3V; V_{I} = 0.8V$		75	130		
I _{HOLD}		$V_{CC} = 3V; V_{I} = 2.0V$		-75	-140		μA
	Data inputs ⁷	$V_{CC} = 0V$ to 3.6V; $V_{CC} = 3.6V$		±500			
I_{EX}	Current into an output in the High state when $V_O > V_{CC}$	V _O = 5.5V; V _{CC} = 3.0V			10	125	μΑ
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_{O} = 0.5$ V to V_{CC} ; $V_{I} = GNE$ $\overline{OE} = Don't$ care	$V_{CC} \le 1.2V$; $V_{O} = 0.5V$ to V_{CC} ; $V_{I} = GND$ or V_{CC} $\overline{OE} = Don't$ care		1.0	±100	μΑ
I _{ССН}		V_{CC} = 3.6V; Outputs High, V_I = GND or V_{CC} , I_O = 0			0.06	0.1	
I _{CCL}	Quiescent supply current	V_{CC} = 3.6V; Outputs Low, V_{I} = GND or V	/ _{CC,} I _{O =} 0		3.5	5	mA
I _{CCZ}	1	V_{CC} = 3.6V; Outputs Disabled; V_{I} = GND) or $V_{CC, I_{O}} = 0^5$		0.06	0.1	
ΔI_{CC}	Additional supply current per input pin ²	$V_{CC} = 3V$ to 3.6V; One input at V_{CC} -0.6 Other inputs at V_{CC} or GND	V,		0.04	0.4	mA

NOTES:

1.

All typical values are at V_{CC} = 3.3V and T_{amb} = 25°C. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND 2.

This is the increase in supply current for each input at the specified voltage fever other than V_{CC} of GND. This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From $V_{CC} = 1.2V$ to $V_{CC} = 3.3V \pm 0.3V$ a transition time of 100µsec is permitted. This parameter is valid for $T_{amb} = 25^{\circ}C$ only. Unused pins at V_{CC} or GND. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power. 3.

4.

5.

6.

This is the bus hold overdrive current required to force the input to the opposite logic state. 7.

25V/3AV 18-bit universal bus transceiver (3-State)

74ALVT16601

AC CHARACTERISTICS (3.3V ±0.3V RANGE)

GND = 0V; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to +85°C.

				LIMITS		
SYMBOL	PARAMETER	WAVEFORM	Vc	_C = 3.3V ±0.	3V	UNIT
			MIN	TYP ¹	MAX	
f _{MAX}	Maximum clock frequency	1				MHz
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	2	1.0 1.0	1.5 1.9	2.3 2.9	ns
t _{PLH} t _{PHL}	Propagation delay Clock Low or High LEAB to Bn or LEBA to An	3	1.5 1.5	2.2 2.6	3.5 3.9	ns
t _{PLH} t _{PHL}	Propagation delay CPAB to Bn or CPBA to An	1	1.5 1.5	2.2 2.9	3.3 4.1	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	5 6	1.0 1.0	2.3 1.6	3.9 2.8	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low Level	5 6	1.5 1.5	2.9 2.4	4.1 3.6	ns

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25° C.

AC SETUP REQUIREMENTS (3.3V \pm 0.3V RANGE)

GND = 0V; $t_R = t_F = 2.5$ ns; $C_L = 50$ pF, $R_L = 500\Omega$; $T_{amb} = -40^{\circ}$ C to $+85^{\circ}$ C.

	PARAMETER		LIM	ITS		
SYMBOL		WAVEFORM	V _{CC} = 3.3	UNIT		
			MIN	TYP ¹		
ts(H) ts(L)	Setup time, High or Low An to CPAB or Bn to CPBA	4	1.5 1.5	0.4 0.6	ns	
th(H) th(L)	Hold time, High or Low An to CPAB or Bn to CPBA	4	1.0 1.0	-0.5 -0.3	ns	
ts(H) ts(L)	Setup time, High or Low Clock Low An to LEAB or Bn to LEBA	4	1.0 1.0	-0.5 -0.1	ns	
th(H) th(L)	Hold time, High or Low Clock High An to LEAB or Bn to LEBA	4	1.5 1.5	0.1 0.5	ns	
ts(H) ts(L)	Setup time <u>CEAB</u> before CPAB or <u>CEBA</u> before CPBA	4	1.5 1.0	0.3 0.4	ns	
th(H) th(L)	Hold time CEAB after CPAB or CEBA after CPBA	4	1.5 1.0	0.7 0.3	ns	
tw(H) tw(L)	Pulse width, High or Low CPAB or CPBA	1	2.0 2.0		ns	
tw(H)	LEAB or LEBA pulse width, High	3	1.5		ns	

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25° C.

2.5V/3.3V-18-bit universal bus transceiver (3-State) 查询//4ALVT16601DL1供应商

74ALVT16601

DC ELECTRICAL CHARACTERISTICS (2.5V \pm 0.2V RANGE)

					LIMITS		
SYMBOL	PARAMETER	TEST CONDITIONS		Temp = -40°C to -		+85°C	UNIT
				MIN	TYP ¹	MAX	
V _{IK}	Input clamp voltage	V _{CC} = 2.3V; I _{IK} = -18mA			-0.85	-1.2	V
		$V_{CC} = 2.3$ to 3.6V; $I_{OH} = -100\mu A$		V _{CC} -0.2			
V _{ОН}	High-level output voltage	V _{CC} = 2.3V; I _{OH} = -8mA		1.8			V
		V _{CC} = 2.3V; I _{OL} = 100µA			0.07	0.2	┟───┤
V _{OL}	Low-level output voltage	V _{CC} = 2.3V; I _{OL} = 24mA			0.3	0.5	V
		V _{CC} = 2.3V; I _{OL} = 8mA		1		0.4	1
V _{RST}	Power-up output low voltage ⁷	V_{CC} = 2.7V; I_{O} = 1mA; V_{I} = V_{CC} or GND				0.55	V
		$V_{CC} = 2.7V; V_I = V_{CC}$ or GND	Control pins		0.1	±1	
		$V_{CC} = 0 \text{ or } 2.7 \text{V}; \text{ V}_{\text{I}} = 5.5 \text{V}$		1	0.1	10	
l _l	Input leakage current	$V_{CC} = 2.7V; V_1 = 5.5V$			0.1	20	μA
		$V_{CC} = 2.7V; V_{I} = V_{CC}$	Data pins ⁴		0.1	10	
		$V_{CC} = 2.7V; V_1 = 0$	1		0.1	-5	
I _{OFF}	Off current	$V_{CC} = 0V; V_{I} \text{ or } V_{O} = 0 \text{ to } 4.5V$	•		0.1	±100	μA
I _{HOLD}	Bus Hold current	$V_{CC} = 2.3V; V_1 = 0.7V$			90		μA
	Data inputs ⁶	V _{CC} = 2.3V; V _I = 1.7V			-75		μΑ
I _{EX}	Current into an output in the High state when $V_O > V_{CC}$	$V_{O} = 5.5V; V_{CC} = 2.3V$			10	125	μA
I _{PU/PD}	Power up/down 3-State output current ³	$V_{CC} \le 1.2$ V; $V_O = 0.5$ V to V_{CC} ; $V_I = GNE$ $\overline{OE} = Don't$ care) or V _{CC} ;		1	100	μA
I _{CCH}		V_{CC} = 2.7V; Outputs High, V_{I} = GND or V_{CC} , I_{O} = 0			0.04	0.1	
I _{CCL}	Quiescent supply current	$V_{CC} = 2.7V$; Outputs Low, $V_I = GND$ or V_{CC} , $I_O = 0$			2.5	4.5	mA
I _{CCZ}	1	V_{CC} = 2.7V; Outputs Disabled; V_{I} = GND) or $V_{CC, I_0} = 0^5$		0.04	0.1	
ΔI_{CC}	Additional supply current per input pin ²	V_{CC} = 2.3V to 2.7V; One input at V_{CC} -0. Other inputs at V_{CC} or GND	.6V,		0.01	0.4	mA

NOTES:

1.

2.

All typical values are at $V_{CC} = 2.5V$ and $T_{amb} = 25^{\circ}C$. This is the increase in supply current for each input at the specified voltage level other than V_{CC} or GND This parameter is valid for any V_{CC} between 0V and 1.2V with a transition time of up to 10msec. From $V_{CC} = 1.2V$ to $V_{CC} = 2.5V \pm 0.2V$ a transition time of 100µsec is permitted. This parameter is valid for $T_{amb} = 25^{\circ}C$ only. Unused pins at V_{CC} or GND. 3.

4.

5. I_{CCZ} is measured with outputs pulled up to V_{CC} or pulled down to ground.

Not guaranteed. 6.

7. For valid test results, data must not be loaded into the flip-flops (or latches) after applying power.

25V/3AV-18-bit universal bus transceiver (3-State)

74ALVT16601

AC CHARACTERISTICS (2.5V ±0.2V RANGE)

GND = 0V; $t_R = t_F = 2.5ns$; $C_L = 50pF$; $R_L = 500\Omega$; $T_{amb} = -40^{\circ}C$ to +85°C.

SYMBOL	PARAMETER	WAVEFORM	Vc	_C = 2.5V ±0.	2V	UNIT
			MIN	TYP ¹	MAX	
f _{MAX}	Maximum clock frequency	1				MHz
t _{PLH} t _{PHL}	Propagation delay An to Bn or Bn to An	2	1.0 1.0	1.9 2.5	3.0 3.7	ns
t _{PLH} t _{PHL}	Propagation delay Clock Low or High LEAB to Bn or LEBA to An	3	2.0 2.0	3.1 3.5	4.6 5.2	ns
t _{PLH} t _{PHL}	Propagation delay CPAB to Bn or CPBA to An	1	2.0 2.0	3.4 4.0	5.0 5.9	ns
t _{PZH} t _{PZL}	Output enable time to High and Low level	5 6	2.0 1.0	3.3 2.1	4.8 3.2	ns
t _{PHZ} t _{PLZ}	Output disable time from High and Low Level	5 6	1.5 1.0	2.6 1.9	4.2 3.4	ns

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25° C.

AC SETUP REQUIREMENTS (2.5V \pm 0.2V RANGE)

GND = 0V; $t_R = t_F = 2.5$ ns; $C_L = 50$ pF, $R_L = 500\Omega$; $T_{amb} = -40^{\circ}$ C to $+85^{\circ}$ C.

			LIMITS		UNIT
SYMBOL	PARAMETER	WAVEFORM	V _{CC} = 2.5V ±0.2V		
			MIN	TYP ¹	
ts(H) ts(L)	Setup time, High or Low An to CPAB or Bn to CPBA	4	2.0 2.0	0.4 1.2	ns
th(H) th(L)	Hold time, High or Low An to CPAB or Bn to CPBA	4	0.0 0.0	-1.1 -0.3	ns
ts(H) ts(L)	Setup time, High or Low Clock Low or High An to LEAB or Bn to LEBA	4	0.0 1.5	-1.0 0.4	ns
th(H) th(L)	Hold time, High or Low Clock Low or High An to LEAB or Bn to LEBA	4	1.5 1.9	0.4 1.0	ns
ts(H) ts(L)	Setup time CEAB before CPAB or CEBA before CPBA	4	1.0 0.3	0.3 -0.4	ns
th(H) th(L)	Hold time CEAB after CPAB or CEBA after CPBA	4	2.0 0.5	0.4 0.1	ns
tw(H) tw(L)	Pulse width, High or Low CPAB or CPBA		3.0 3.0		ns
tw(H)	LEAB or LEBA pulse width, High	3	1.5		ns

NOTE:

1. All typical values are at V_{CC} = 3.3V and T_{amb} = 25° C.

V/3.3V-18-bit universal bus transceiver (3-State) 26

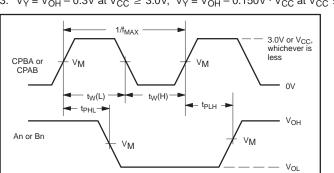
SW00181

74ALVT16601

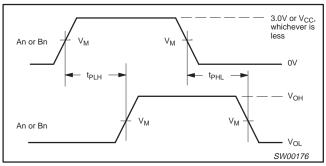
AC WAVEFORMS

NOTES:

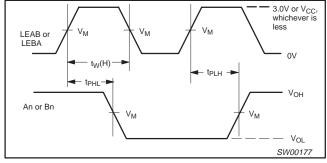
- 1. $V_{M} = 1.5V$ at $V_{CC} \ge 3.0V$, $V_{M} = V_{CC}/2$ at $V_{CC} \le 2.7V$ 2. $V_{X} = V_{OL} + 0.3V$ at $V_{CC} \ge 3.0V$, $V_{X} = V_{OL} + 0.150V \cdot V_{CC}$ at $V_{CC} \le 2.7V$ 3. $V_{Y} = V_{OH} 0.3V$ at $V_{CC} \ge 3.0V$, $V_{Y} = V_{OH} 0.150V \cdot V_{CC}$ at $V_{CC} \le 2.7V$



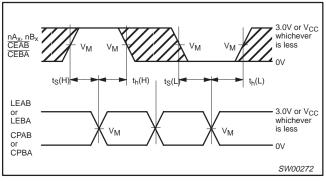
Waveform 1. Propagation Delay, Clock Input to Output, Clock Pulse Width, and Maximum Clock Frequency



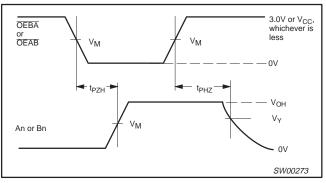
Waveform 2. Propagation Delay, Transparent Mode



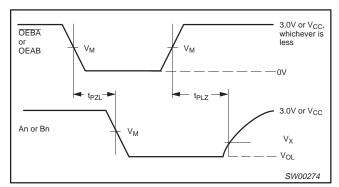
Waveform 3. Propagation Delay, Enable to Output, and Enable **Pulse Width**



Waveform 4. Data Setup and Hold Times



Waveform 5. 3-State Output Enable Time to High Level and Output Disable Time from High Level

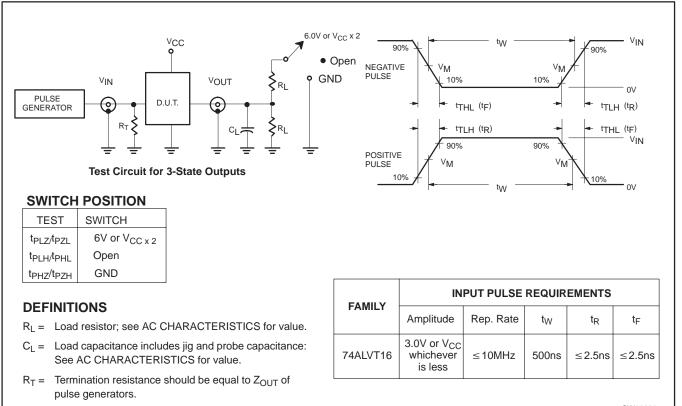


Waveform 6. 3-State Output Enable Time to Low Level and Output Disable Time from Low Level

25V/33V-18-bit universal bus transceiver (3-State)

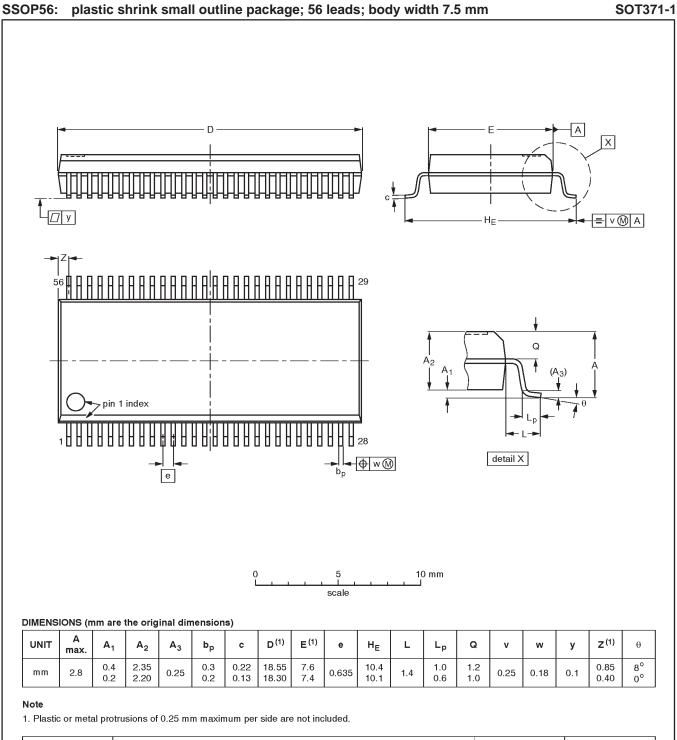
74ALVT16601

TEST CIRCUIT



18-bit universal bus transceiver (3-State) 查询"74ALVT16601DL"供应商

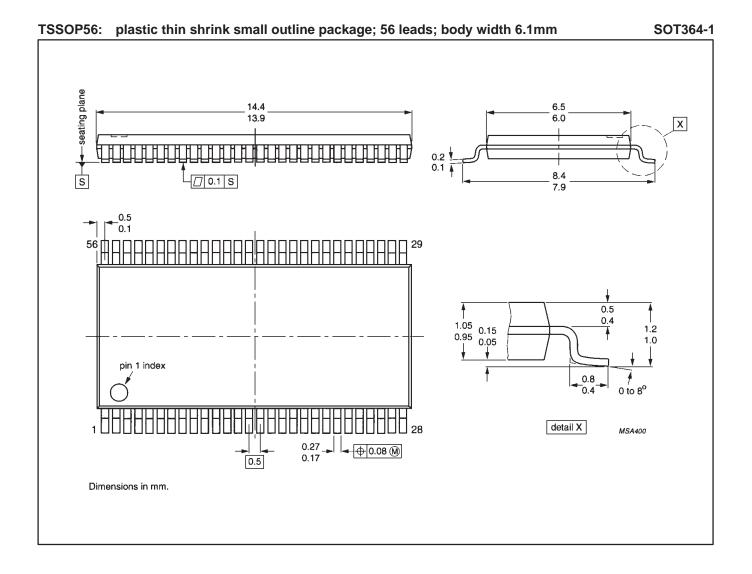
74ALVT16601



OUTLINE		REFER	ENCES	EUROPEAN	ISSUE DATE
VERSION	IEC	JEDEC	EIAJ	PROJECTION	ISSUE DATE
SOT371-1		MO-118AB			-93-11-02 95-02-04

18-bit universal bus transceiver (3-State) 查询"74ALVT16601DL"供应商

74ALVT16601



18-bit universal bus transceiver (3-State) 查询"74ALVT16601DL"供应商

74ALVT16601

NOTES

18 bit universal bustransceiver (3-State)

Data sheet status

Data sheet status	Product status	Definition [1]
Objective specification	Development	This data sheet contains the design target or goal specifications for product development. Specification may change in any manner without notice.
Preliminary specification	Qualification	This data sheet contains preliminary data, and supplementary data will be published at a later date. Philips Semiconductors reserves the right to make chages at any time without notice in order to improve design and supply the best possible product.
Product specification	Production	This data sheet contains final specifications. Philips Semiconductors reserves the right to make changes at any time without notice in order to improve design and supply the best possible product.

[1] Please consult the most recently issued datasheet before initiating or completing a design.

Definitions

Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

Application information — Applications that are described herein for any of these products are for illustrative purposes only. Philips Semiconductors make no representation or warranty that such applications will be suitable for the specified use without further testing or modification.

Disclaimers

Life support — These products are not designed for use in life support appliances, devices or systems where malfunction of these products can reasonably be expected to result in personal injury. Philips Semiconductors customers using or selling these products for use in such applications do so at their own risk and agree to fully indemnify Philips Semiconductors for any damages resulting from such application.

Right to make changes — Philips Semiconductors reserves the right to make changes, without notice, in the products, including circuits, standard cells, and/or software, described or contained herein in order to improve design and/or performance. Philips Semiconductors assumes no responsibility or liability for the use of any of these products, conveys no license or title under any patent, copyright, or mask work right to these products, and makes no representations or warranties that these products are free from patent, copyright, or mask work right infringement, unless otherwise specified.

Philips Semiconductors 811 East Arques Avenue P.O. Box 3409 Sunnyvale, California 94088–3409 Telephone 800-234-7381 © Copyright Philips Electronics North America Corporation 1998 All rights reserved. Printed in U.S.A.

print code

Document order number:

Date of release: 05-96 9397-750-03571

Let's make things better.



PHILIPS